

1. CERTIFICATION

STANDARDS OF TEST METHOD:

EN 55022: 2006 AND

EN 61000-3-2: 2006 & EN 61000-3-3: 1995 + A1: 2001 + A2: 2005

EN 55024: 1998 + A1: 2001 + A2: 2003 AND IEC 61000-4 SERIES REGULATIONS

GENERAL REMARKS:

The tests were performed according to the technical requirement of EUT.

- ☒ Electro-magnetic Radiated Emission Interference Measurement (EN 55022)
- ☒ Electro-magnetic Conducted Emission Interference Measurement (EN 55022)
- ☒ Harmonic Current Emissions (EN 61000-3-2)
- ☒ Voltage Fluctuation and Flicker Measurement (EN 61000-3-3)
- ☒ ESD Immunity Test (IEC 61000-4-2)
- ☒ RF Field strength Susceptibility Test (IEC 61000-4-3)
- ☒ Electrical Fast Transient/Burst Immunity Test (IEC 61000-4-4)
- ☒ Surge Immunity Test (IEC 61000-4-5)
- ☒ Conducted disturbance Susceptibility Test (IEC 61000-4-6)
- ☐ Low Frequency Signals Immunity Test (IEC 1000-2-2)
- ☒ Power Frequency Magnetic Field Immunity Test (IEC 61000-4-8)
- ☒ Voltage Dips/Short Interruptions Test (IEC 61000-4-11)

☒ **AS/NZS CISPR 22** Limits and Methods of Measurement of Radio Interference Characteristics of Information Technology equipment :2006

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In order to ensure the quality and accuracy of this document, the contents have been thoroughly reviewed by the following qualified personnel from GesTek Lab.

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